#### Likelihood Ratios for Out-of-Distribution Detection

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#### Outline

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- Likelihood Ratio for OOD detection
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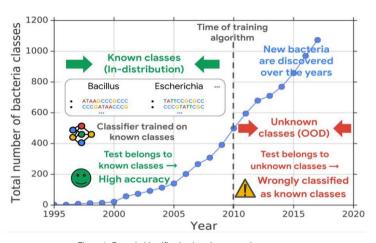


Figure 1: Bacteria identification based on genomic sequences

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  - Supervised: Classifier-based approaches
    - "Need accurate OOD detection to ensure safe deployment of classifier"

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#### Introduction

#### In-distribution dataset **D** of (x,y) pairs sampled from the distribution p\*(x,y):

- $x_d \in [A,C,G,T]$  for genomic sequences and  $x_d \in [0,...,255]$  for images
- $\bullet$  y  $\in$  Y := [1,...,k,...,K] is the label



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#### Existing methods:

- Classifier-based: taking the confidence or entropy of the predictive distribution p(y|x)
- ullet Density-based: fit a generative model p(x) to the input data, and then evaluate the likelihood of new inputs under that model

# Background

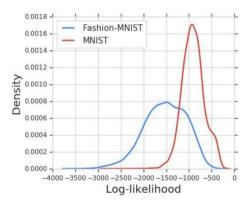


Figure 2: MNIST (OOD) vs Fashion-MNIST (in-dist.) Prior work [Nalisnick et al., 2018, Choi et al. 2019]

## Background

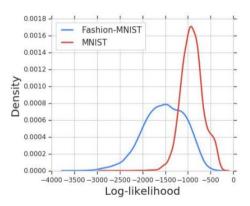


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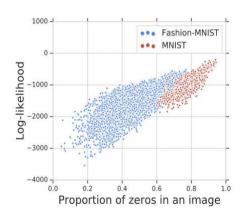


Figure 3: Likelihood is highly correlated with the background

# High level idea 1/2

#### Background vs Semantic Component:

Assume that an input  $\mathbf{x}$  is composed of two components:

$$x = x_B + x_S$$

- Background component  $(x_B)$  characterized by population level background statistics
- Semantic component  $(x_S)$  characterized by patterns specific to the in-distribution data

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#### Background vs. Semantics Examples:

- Images: background + object
- Text: stop words + key words
- Genomics: GC content + motifs
- Speech: background noise + speaker

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# High level idea 2/2

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Assume that  $p_{\theta}$  is a model trained using in-distribution data, and  $p_{\theta_0}$  is a background model that captures general background statistics. A likelihood ratio statistic can be defined as:

$$LLR(x) = \log \frac{p_{\theta}(x)}{p_{\theta_0}(x)} = \log \frac{p_{\theta}(x_B)p_{\theta}(x_S)}{p_{\theta_0}(x_B)p_{\theta_0}(x_S)}$$
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Assume that both models capture the background information equally well:

$$LLR(x) = log(p_{\theta}(x_S)) - log(p_{\theta_0}(x_S))$$

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## Likelihood Ratio for OOD detection 1/2

#### Algorithm 1:Training the Background Model

- Inputs: D-dimensional input  $x = x_1...x_D$ ,  $x_d \in F$ , where F = [A,C,G,T] or [0,...,255]
- Output: perturbed input  $\bar{x}$

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```
• for index d \in [1, ..., D] if v_d=1 Sample \bar{x_d} from the set F with equal probability else \bar{x_d}=x_d end
```

end

# Likelihood Ratio for OOD detection 2/2

#### Algorithm 2: OOD detection using Likelihood Ratio

• **Inputs:** D-dimensional test input  $x = x_1...x_D$ 

• Output: Predict OOD

# Likelihood Ratio for OOD detection 2/2

#### Algorithm 2: OOD detection using Likelihood Ratio

- **Inputs:** D-dimensional test input  $x = x_1...x_D$
- Output: Predict OOD
- Fit a model  $p_{\theta}(x)$  using in-distribution data-set  $D_{in}$
- Fit a background model  $p_{\theta_0}(x)$  using perturbed input data  $\bar{D}_{in}$  (generated using Algorithm 1) and (optionally) model regularization techniques
- Compute the likelihood ratio statistic:

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Predict OOD if LLR(x) is small

- Fashion-MNIST (in-dist.) vs. MNIST (OOD): PixelCNN++ model is trained on Fashion-MNIST
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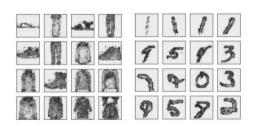


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Figure 4: likelihood of pixels

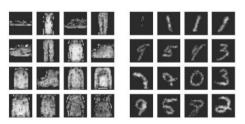


Figure 5: Likelihood ratio of pixels Advanced Design, Optimization and Probabilistic Techniques laboratory

#### Error Metric

- AUROC↑: Area under the ROC curve
- AUPRC: Area under the precision-recall curve
- FPR80↓: False positive rate at 80 percent true positive rate

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- FPR80↓: False positive rate at 80 percent true positive rate

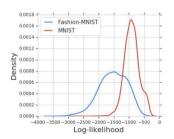


Figure 6: Log-likelihood is lower for Fashion-MNIST (in-dist) than MNIST (OOD)

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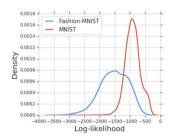


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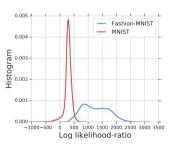


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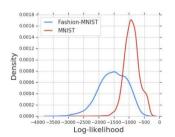


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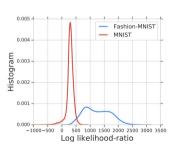


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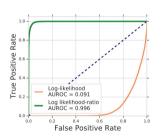


Figure 8: Likelihood ratio significantly inprovince the ad AUROC of OOD detection through the temporal subgratory

- 10 in-distribution, 60 OOD validation, 60 OOD test
- Classes split by year to reflect challenges faced when classifier trained only on known classes



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Figure 9: Genomic sequence data-set

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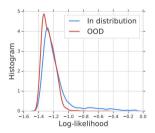


Figure 10: Log-likelihood hardly separates in-distribution and OOD input



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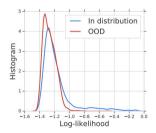


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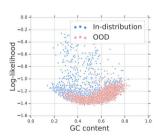


Figure 11: The log-likelihood is heavily affected by the GC-content of a sequence



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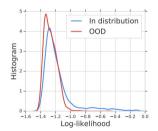


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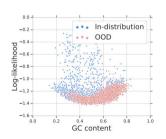


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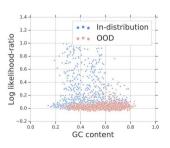


Figure 12: Corrected GC-content of a seguence Advanced besign, optimization and Probabilistic Techniques laboratory

- LSTM model is trained using sequences from in-distribution classes
- Likelihood Ratio significantly improves OOD Detection
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- OOD detection correlates with its distance to in-distribution



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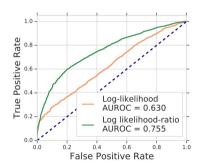


Figure 13: AUROC for likelihood and LLR

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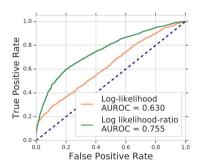


Figure 13: AUROC for likelihood and LLR

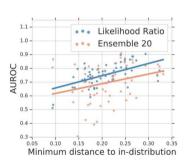


Figure 14: Correlation between the AUROC place and distance to in-distribution classes Probabilistic Techniques laborator

## Comparison with baseline methods

	<b>AUROC</b> ↑	<b>AUPRC</b> ↑	FPR80↓
Likelihood	0.626 (0.001)	0.613 (0.001)	0.661 (0.002)
Likelihood Ratio (ours, $\mu$ )	0.732 (0.015)	0.685 (0.017)	0.534 (0.031)
Likelihood Ratio (ours, $\mu$ , $\lambda$ )	0.755 (0.005)	0.719 (0.006)	0.474 (0.011)
$p(\hat{y} oldsymbol{x})$	0.634 (0.003)	0.599 (0.003)	0.669 (0.007)
Entropy of $p(y x)$	0.634 (0.003)	0.599 (0.003)	0.617 (0.007)
Adjusted ODIN	0.697 (0.010)	0.671 (0.012)	0.550 (0.021)
Mahalanobis distance	0.525 (0.010)	0.503 (0.007)	0.747 (0.014)
Ensemble, 5 classifiers	0.682 (0.002)	0.647 (0.002)	0.589 (0.004)
Ensemble, 10 classifiers	0.690 (0.001)	0.655 (0.002)	0.574 (0.004)
Ensemble, 20 classifiers	0.695 (0.001)	0.659 (0.001)	0.570 (0.004)
Binary classifier	0.635 (0.016)	0.634 (0.015)	0.619 (0.025)
$p(\hat{y} \boldsymbol{x})$ with noise class	0.652 (0.004)	0.627 (0.005)	0.643 (0.008)
$p(\hat{y} x)$ with calibration	0.669 (0.005)	0.635 (0.004)	0.627 (0.006)
WAIC, 5 models	0.628 (0.001)	0.616 (0.001)	0.657 (0.002)

Figure 15: Error metric for genomic sequence using different methods

## Summary

- Create a realistic benchmark dataset for OOD detection (and open-set classification) in genomics
- Show that the likelihood from deep generative models can be confounded by background statistics
- Propose a likelihood ratio method for unsupervised OOD detection, outperforming the raw likelihood
- Proposed method performs well on images and achieves state of the art (SOTA)
   performance on genomic dataset

## Review/Comments

- Author assumes that background and semantic component of input are independent, which may not be true in many practical application
- GC content of a sequence is similarly a function of the semantic component when classifying bacterial sequences
- The AUROC being significantly worse than random on the Fashion MNIST dataset isn't explained
- Given the experimental evidence and the novelty of the method, it is important contribution for OOD detection
- Given the genomics sequence, this method can be used for finding out new strain of COVID'19
- Proposed method can be used for early detection of disease, which is significant contribution in respective area

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#### From the News

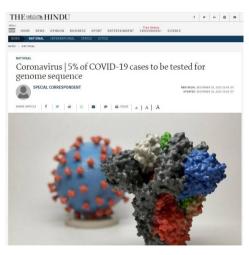


Figure 16: New variant of COVID'19 identification based on genomic sequencing

#### References

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# Thank You



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